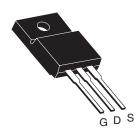


STP16NF06FP-VB Datasheet N-Channel 60 V (D-S) MOSFET

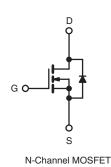
PRODUCT SUMMARY						
V _{DS} (V)	60					
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.027				
Q _g (Max.) (nC)	95					
Q _{gs} (nC)	27					
Q _{gd} (nC)	46					
Configuration	Single					

FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- Low Thermal Resistance
- · Lead (Pb)-free Available



TO-220 FULLPAK



ABSOLUTE MAXIMUM RATINGS T_C = 25 °C, unless otherwise noted SYMBOL PARAMETER LIMIT UNIT 60 **Drain-Source Voltage** V_{DS} v Gate-Source Voltage ± 20 V_{GS} $T_C = 25 \ ^{\circ}C$ 45 V_{GS} at 10 V **Continuous Drain Current** I_D $T_C = 100 \degree C$ А 30 Pulsed Drain Currenta I_{DM} 220 Linear Derating Factor 0.32 W/°C Single Pulse Avalanche Energy^b E_{AS} 100 mJ T_C = 25 °C Maximum Power Dissipation 52 W P_D Peak Diode Recovery dV/dtc dV/dt V/ns 4.5 Operating Junction and Storage Temperature Range T_J, T_{stg} - 55 to + 175 °C Soldering Recommendations (Peak Temperature) for 10 s 300^d 10 lbf · in Mounting Torque 6-32 or M3 screw N·m 1.1

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 129 μ H, $R_G = 25 \Omega$, $I_{AS} = 30 \text{ A}$ (see fig. 12). c. $I_{SD} \le 52 \text{ A}$, dI/dt $\le 250 \text{ A}/\mu$ s, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.

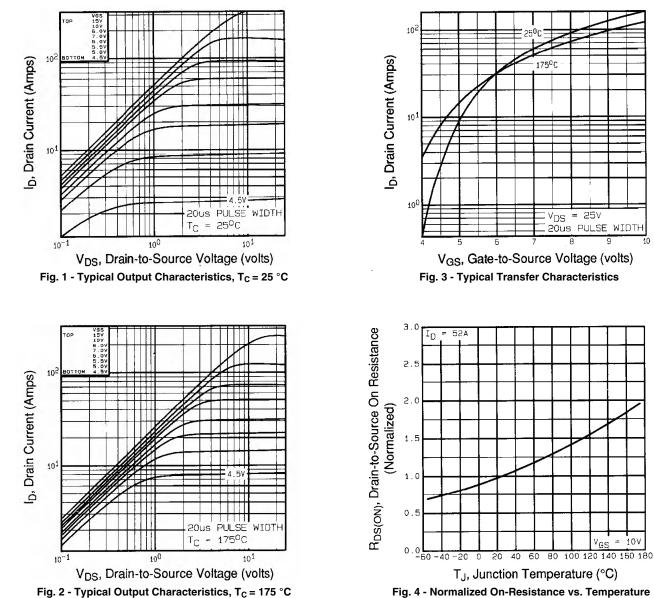


THERMAL RESISTANCE RAT	TINGS								
PARAMETER	SYMBOL	TYP. MAX.			UNIT				
Maximum Junction-to-Ambient	R _{thJA}	- 65			°C AN				
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.1				- °C/W			
SPECIFICATIONS $T_J = 25 \degree C$,	unless otherw	vise noted							
PARAMETER	SYMBOL	1	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT	
Static					1		1	1	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA			60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, $I_D = 1 \text{ mA}$			-	0.060	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$			1.0	-	3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$			-	-	± 100	nA	
	466		$V_{DS} = 60 V, V_{GS} = 0 V$			-	25	μΑ	
Zero Gate Voltage Drain Current	$V_{DS} = 48 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 150 ^{\circ}\text{C}$		T _J = 150 °C	-	-	250			
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V I _D = 18 A ^b			-	0.027	-	Ω	
Forward Transconductance	9 _{fs}	$V_{DS} = 25 \text{ V}, \text{ I}_{D} = 18 \text{ A}^{b}$		15	-	-	S		
Dynamic						•		1	
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	1500	-	pF		
Output Capacitance	C _{oss}			-	720	-			
Reverse Transfer Capacitance	C _{rss}			-	100	-			
Drain to Sink Capacitance	С			-	12	-			
Total Gate Charge	Qg				-	-	95	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		$2 \text{ A}, \text{ V}_{\text{DS}} = 48 \text{ V},$	-	-	27		
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^b		-	-	46		
Turn-On Delay Time	t _{d(on)}	V _{DD} = 30 V, I _D = 52 A, R _G = 9.1 Ω, R _D = 0.54 Ω, see fig. 10 ^b		-	19	-	- ns		
Rise Time	tr			-	120	-			
Turn-Off Delay Time	t _{d(off)}			-	55	-			
Fall Time	t _f			-	86	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	Ls			-	7.5	-			
Drain-Source Body Diode Characteristic	s					•			
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	45	A		
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode			-	-		120	
Body Diode Voltage	V_{SD}	$T_{J} = 25 \text{ °C}, I_{S} = 30 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 52 A, dl/dt = 100 A/µs ^b		-	140	300	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	$I_{J} = 25$ °C, $I_{F} = 52$ A, $ai/at = 100$ A/ μ S			-	1.2	2.8	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time i	s negligible (turn	-on is dor	ninated by	y L _S and I	_D)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.

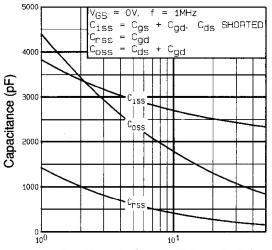




TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

10V





V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

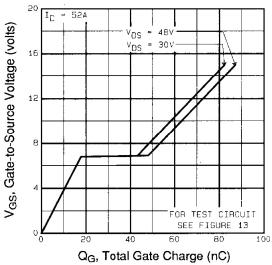


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

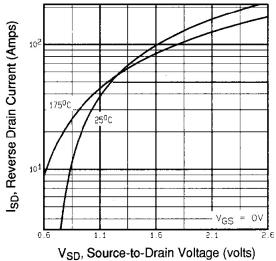
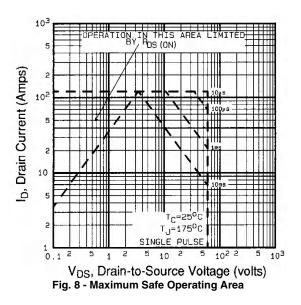


Fig. 7 - Typical Source-Drain Diode Forward Voltage





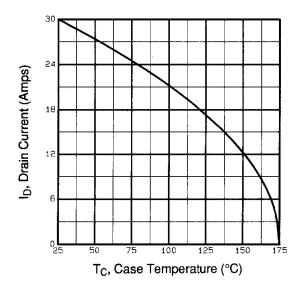


Fig. 9 - Maximum Drain Current vs. Case Temperature

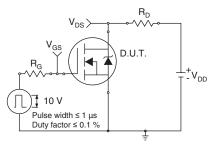


Fig. 10a - Switching Time Test Circuit

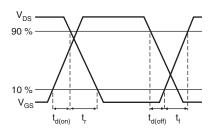


Fig. 10b - Switching Time Waveforms

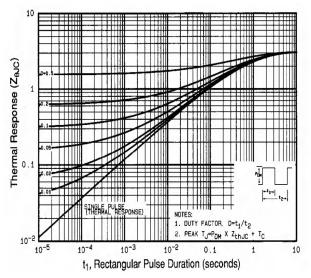


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

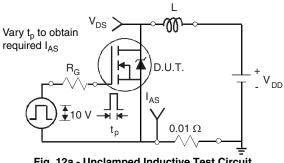


Fig. 12a - Unclamped Inductive Test Circuit

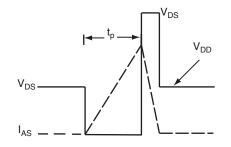
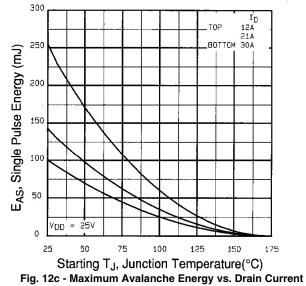
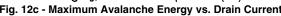


Fig. 12b - Unclamped Inductive Waveforms







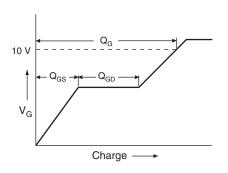
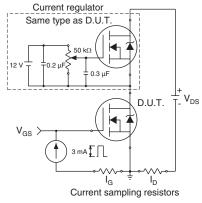
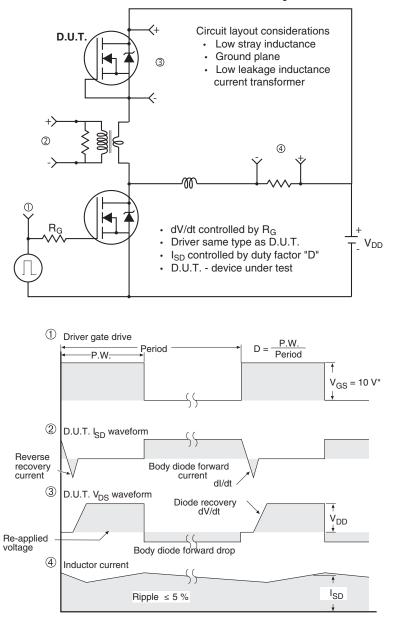


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



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